

CERTIFICATE OF EMC

CERTIFICATE NO.: SET2015-01567

Product: Main board

Model: BL2000-STB-V* (*=9-9.99, indicate the different customer or/and Software function number)

Applicant: ShenYang Bluelight Automatic Technology Co., Ltd.

Address: No. 37 Shiji Road, Hunnan New District, Shenyang, China

This is to certify that, on the basis of the tests undertaken as per Report No. **SET2015-01567**, the submitted sample of the above item complies with:

EN61000-6-4:2007+A1:2011

EN61000-6-2:2005

and fulfils testing requirement of the EMC directive 2004/108/EC

Signed for and on behalf of
CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd.



Wu Li An, Vice Director

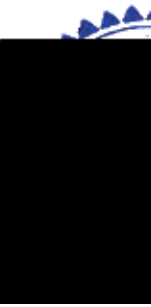
Date of Issue: Feb. 06, 2015

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查询码: 6PA7ZR5b

Report No.

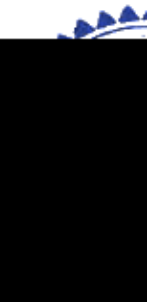


Table of Contents

Report.....2

1 General Information.....5

 1.1 Description of EUT..... 5

4.5 Electrical Fast Transient Burst Immunity Test.....	14
4.5.1 Test Specification	14
4.5.2 Test Setup	14
4.5.3 Test Results	15
4.6 Surge Immunity Test.....	15
4.6.1 Test Specification	15
4.6.2 Test Setup	15
4.6.3 Test Results	15
4.7 Immunity to Conducted Disturbances Induced by RF Fields.....	16
4.7.1 Test Specification	16
4.7.2 Test Setup	16
4.7.3 Test Results	16
4.8 Power Frequency Magnetic Field Immunity Test.....	17
4.8.1 Test Specification	17
4.8.2 Test Setup	17
4.8.3 Test Results	17
Appendix I Photographs of the EUT.....	18
Appendix II Photographs of EMC Test Configuration	19

1 General Information

1.1 Description of EUT

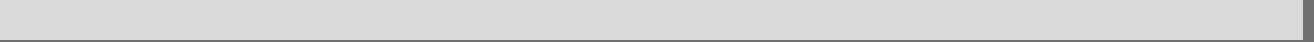
Main board
BL2000-STB-V9.0
/
/
Input 5V DC, 24V DC
/

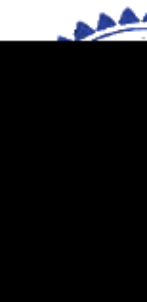
NOTE:

1. For more detailed features description about the EUT, please refer to User Manual.
2. Application model is BL2000-STB-V* (*=9-9.99, indicate the different customer or software function number). Models differences do not affect the performance of EMC. All test

2.3 Test Standards and Results

The EUT has been tested according to the following specifications





3 Emission Test

3.1 EUT Setup and Operating Conditions

The EUT is powered by 5V DC and 24V DC mains. The EUT is continuously operated during the test.

3.2 Radiated Disturbance Measurement

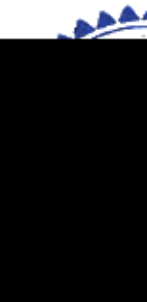
3.2.1 Limits of Radiated Disturbance

Frequency range (MHz)	Quasi peak limits(dB μ V/m), at 10m measurement distance
30 -230	40
230 - 1000	47

Notes:

- (1) The lower limit shall apply at the emission frequency
- (2) Additional provisions may be required for co-existence interference cases

3.2.2 Test Setup



1. Electromagnetic radiation disturbances max peak detector antenna polarization: Vertical

2. Electromagnetic radiation disturbances max peak detector antenna polarization: Horizontal

4 Immunity Test

4.1 EUT Setup and Operating Conditions

Same as 3.1.

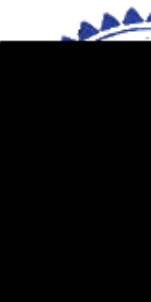
4.2 Performance Criteria

Criterion A	The apparatus shall continue to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the apparatus is intended.
Criterion B	The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the apparatus is intended.
Criterion C	Temporary loss of function is allowed, provided the function is self-recoverable or can be reset by the operator or the control system.

4.3 Electrostatic Discharge Immunity Test

4.3.1 Test Specification

Basic Standard:	IEC 61000-4-2
Discharge Impedance	330 Ω / 150 pF
Discharge Voltage:	Air Discharge: 8 kV Contact Discharge: 4 kV
Polarity:	Positive / Negative
Number of Discharge:	Minimum 20 times at each test point
Discharge Mode:	Single discharge
Discharge Period:	1-second minimum
Criterion:	B

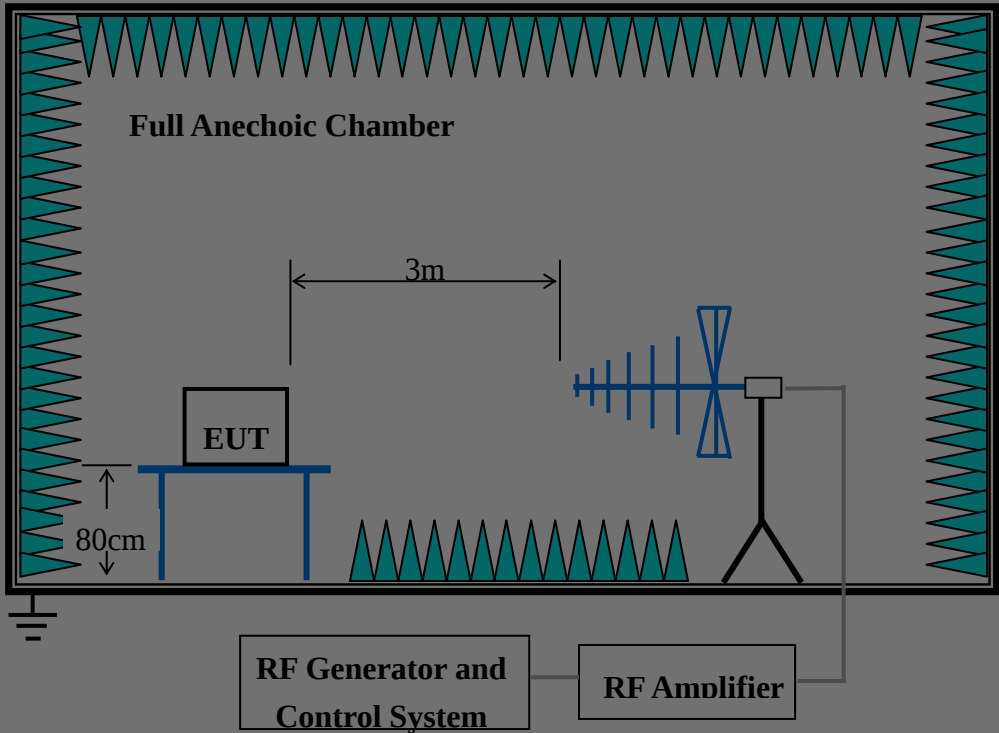


4.4 Radiated, Radio Frequency Electromagnetic Field Immunity Test

4.4.1 Test Specification

Basic Standard:	EN 61000-4-3		
Frequency Range:	80 MHz-1000MHz	1.4GHz-2.0GHz	2.0GHz-2.7GHz
Field Strength:	10V/m	3V/m	1V/m
Modulation:	1kHz sine wave, 80%, AM modulation		
Frequency Step:	1% of fundamental		
Polarity of Antenna	Horizontal and Vertical		
Test Distance:	3m		
Antenna Height:	1.5m		
Dwell Time:	3 seconds		
Criterion:	A		

4.4.2 Test Setup



4.4.3 Test Result

Frequency	Polarity	Azimuth	Field Strength (V/m)	Observation	Comply with Criterion
80-1000 MHz	V&H	0,90, 80, 270	10	Note(1)	A
1.4-2.0GHz	V&H	0,90, 80, 270	3	Note(1)	A
2.0-2.7GHz	V&H	0,90, 80, 270	1	Note(1)	A

NOTE:

(1). The EUT continued to operate as intended. No degradation of performance observed.

4.5 Electrical Fast Transient/Burst Immunity Test

4.5.1 Test Specification

Basic Standard: IEC 61000-4-4

For the actual test configuration, please refer to Appendix II Configuration.

Photographs of the Test

4.5.3 Test Result

Test Point	Polarity	Test Level (kV)	Observation	Comply with Criterion
DC. power	+/-	2	Note (1)	A
Signal port	+/-	1	Note (1)	A

NOTE:

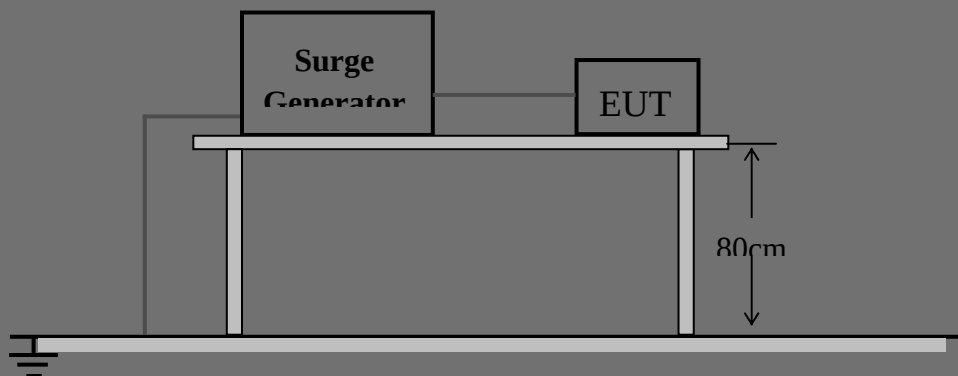
(1). The EUT continued to operate as intended. No degradation of performance was observed.

4.6 Surge Immunity Test

4.6.1 Test Specification

Basic Standard:	IEC 61000-4-5
Waveform:	Voltage 1.2/50 μ s, Current 8/20 μ s
Test Voltage:	DC power port line to line 0.5 kV, line to earth 0.5 kV
Polarity:	Positive/Negative
Repetition Rate:	60/s
Times:	5 time/each condition.
Criterion:	B

4.6.2 Test Setup



4.6.3 Test Result

Coupling Line	Polarity	Voltage (kV)	Observation	Comply with Criterion
DC power Line-Line	+/-	0.5	Note (1)	A

NOTE:

(1). The EUT continued to operate as intended. No degradation of performance was observed.

4.7 Immunity to Conducted Disturbances Induced by RF Fields

4.7.1 Test Specification

Basic Standard:	IEC 61000-4-6
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4.8 Power Frequency Magnetic Field Immunity Test

4.8.1 Test Specification

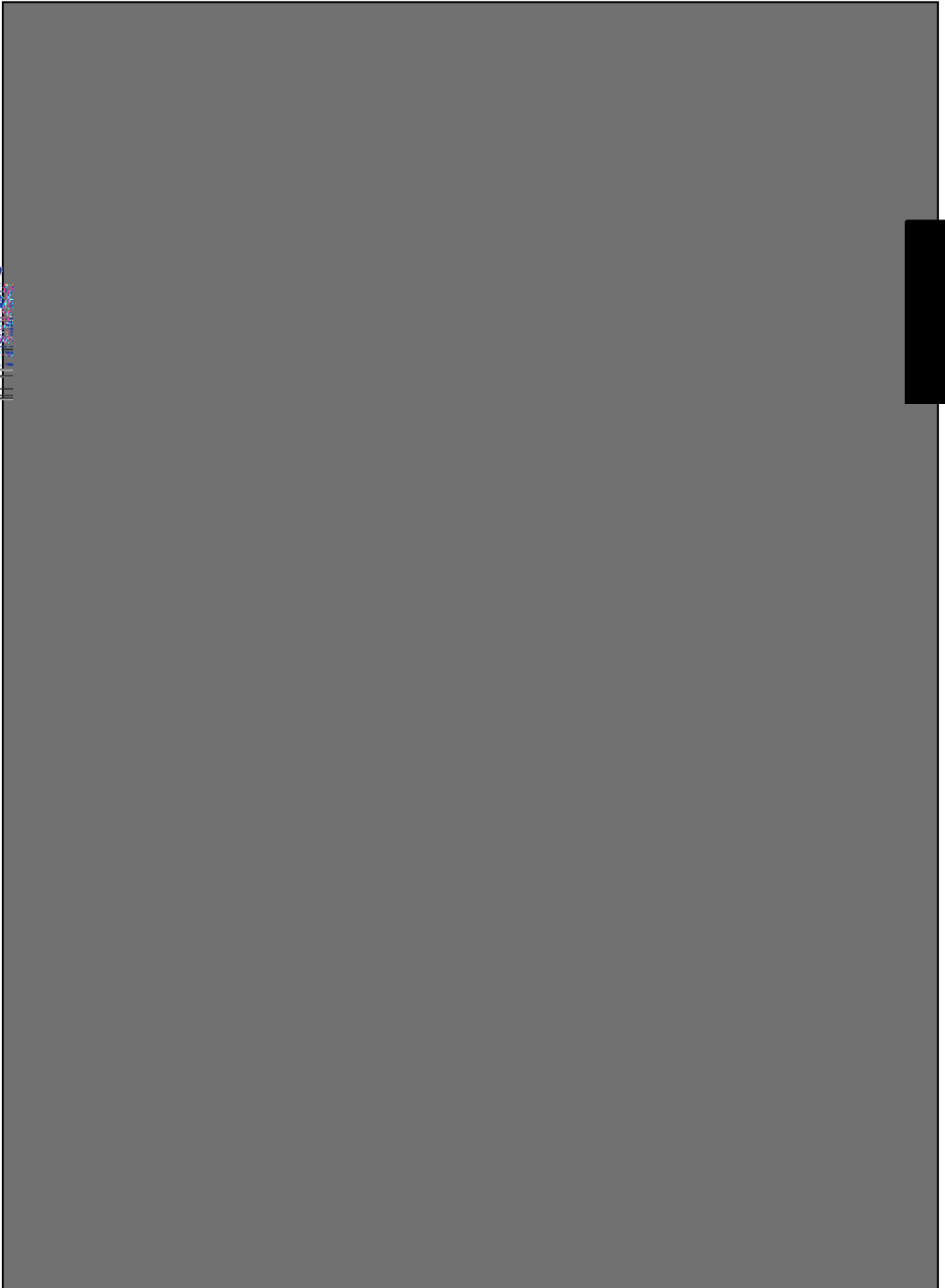
Basic Standard:	IEC 61000-4-8
Frequency Range:	50Hz

Appendix I Photographs of the EUT



Appendix II Photographs of EMC Test Configuration





5. Electrical Fast Transient/Burst Immunity Test

6. Surge Immunity Test

7. Immunity to Conducted Disturbances Induced by RF Fields

8. Power Frequency magnetic Field Immunity

STATEMENT

This test laboratory is accredited by CNAS, Accreditation Certificate No.L1659.

- 2. The test report is invalid without stamp of laboratory.**
- 3. The test report is invalid without signature of person(s) testing and authorizing.**
- 4. The test report is invalid if erased and corrected.**
- 5. Test results of the report is valid to the test samples if sampling by client.**
- 6. This item cannot be Accredited by CNAS.**
- 7. The test report shall not be reproduced except in full, without written approval of the laboratory.**
- 8. If there is any objection to report, the client should inform issuing laboratory within 15 days from the date of receiving test report.**

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